



# STT3PF20V

P-CHANNEL 20V - 0.14  $\Omega$  - 2.2A SOT23-6L  
2.7-DRIVE STripFET™ II POWER MOSFET

| TYPE      | V <sub>DSS</sub> | R <sub>DS(on)</sub>                                | I <sub>D</sub> |
|-----------|------------------|--|----------------|
| STT3PF20V | 20 V             | < 0.20 $\Omega$ (@4.5V)<br>< 0.25 $\Omega$ (@2.7V) | 2.2 A          |

- TYPICAL R<sub>DS(on)</sub> = 0.14  $\Omega$  (@4.5V)
- TYPICAL R<sub>DS(on)</sub> = 0.20  $\Omega$  (@2.7V)
- ULTRA LOW THRESHOLD GATE DRIVE (2.7V)
- STANDARD OUTLINE FOR EASY AUTOMATED SURFACE MOUNT ASSEMBLY

## DESCRIPTION

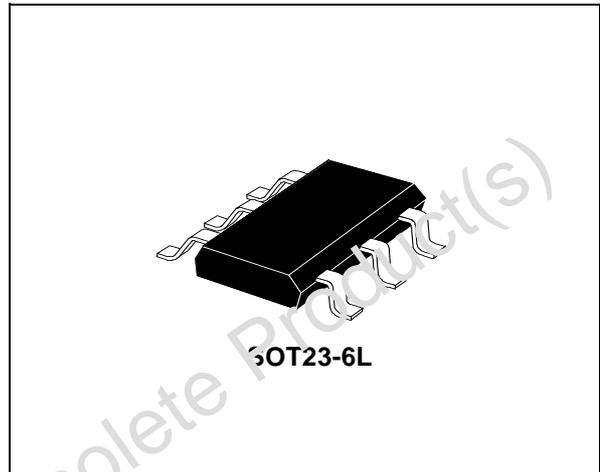
This Power MOSFET is the latest development of STMicroelectronics unique "Single Feature Size™" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics and less critical alignment steps therefore a remarkable manufacturing reproducibility.

## APPLICATIONS

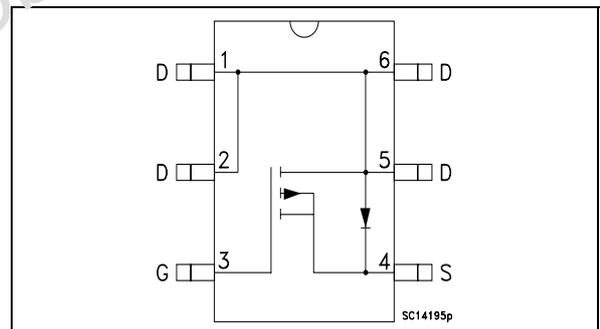
- DC-DC CONVERTERS
- BATTERY MANAGEMENT IN NOMADIC EQUIPMENT
- CELLULAR

## MARKING

- STP2



## INTERNAL SCHEMATIC DIAGRAM



## ABSOLUTE MAXIMUM RATINGS

| Symbol              | Parameter   | Value    | Unit |
|---------------------|---|----------|------|
| V <sub>DS</sub>     | Drain-source Voltage (V <sub>GS</sub> = 0)            | 20       | V    |
| V <sub>DGR</sub>    | Drain-gate Voltage (R <sub>GS</sub> = 20 k $\Omega$ ) | 20       | V    |
| V <sub>GS</sub>     | Gate- source Voltage                                  | $\pm$ 12 | V    |
| I <sub>D</sub>      | Drain Current (continuous) at T <sub>C</sub> = 25°C   | 2.2      | A    |
| I <sub>D</sub>      | Drain Current (continuous) at T <sub>C</sub> = 100°C  | 1.39     | A    |
| I <sub>DM</sub> (●) | Drain Current (pulsed)                                | 8.8      | A    |
| P <sub>tot</sub>    | Total Dissipation at T <sub>C</sub> = 25°C            | 1.6      | W    |

(●) Pulse width limited by safe operating area.

Note: P-CHANNEL MOSFET actual polarity of voltages and current has to be reversed

# STT3PF20V

## THERMAL DATA

|                                |  |     |                                |                  |
|--------------------------------|--|-----|--------------------------------|------------------|
| Rthj-amb<br>$T_j$<br>$T_{stg}$ | (*)Thermal Resistance Junction-ambient<br>Max. Operating Junction Temperature<br>Storage Temperature | Max | 78<br>-55 to 150<br>-55 to 150 | °C/W<br>°C<br>°C |
|--------------------------------|--|-----|--------------------------------|------------------|

(\*) Mounted on a 1 inch pad of 2 oz. Cu in FR-4 board

(\*\*) Mounted on a minimum pad of 2 oz. Cu in FR-4 board

## ELECTRICAL CHARACTERISTICS ( $T_{case} = 25\text{ °C}$ unless otherwise specified)

### OFF

| Symbol        | Parameter  | Test Conditions   | Min. | Typ. | Max.      | Unit               |
|---------------|--|---|------|------|-----------|--------------------|
| $V_{(BR)DSS}$ | Drain-source Breakdown Voltage                   | $I_D = 250\ \mu A, V_{GS} = 0$  | 20   |      |           | V                  |
| $I_{DSS}$     | Zero Gate Voltage Drain Current ( $V_{GS} = 0$ ) | $V_{DS} = \text{Max Rating}$<br>$V_{DS} = \text{Max Rating } T_C = 125\text{ °C}$ |      |      | 1<br>10   | $\mu A$<br>$\mu A$ |
| $I_{GSS}$     | Gate-body Leakage Current ( $V_{DS} = 0$ )       | $V_{GS} = \pm 12\text{ V}$  |      |      | $\pm 100$ | nA                 |

### ON (\*)

| Symbol       | Parameter                         | Test Conditions  | Min. | Typ.         | Max.         | Unit                 |
|--------------|-----------------------------------|--|------|--------------|--------------|----------------------|
| $V_{GS(th)}$ | Gate Threshold Voltage            | $V_{DS} = V_{GS} \quad I_D = 250\ \mu A$   | 0.6  |              |              | V                    |
| $R_{DS(on)}$ | Static Drain-source On Resistance | $V_{GS} = 4.5\text{ V} \quad I_D = 1\text{ A}$<br>$V_{GS} = 2.7\text{ V} \quad I_D = 1\text{ A}$ |      | 0.14<br>0.20 | 0.20<br>0.25 | $\Omega$<br>$\Omega$ |

### DYNAMIC

| Symbol                              | Parameter   | Test Conditions                                      | Min. | Typ.            | Max. | Unit           |
|-------------------------------------|---|--|------|-----------------|------|----------------|
| $g_{fs}$ (*)                        | Forward Transconductance  | $V_{DS} = 15\text{ V} \quad I_D = 1\text{ A}$        |      | 4               |      | S              |
| $C_{iss}$<br>$C_{oss}$<br>$C_{rss}$ | Input Capacitance<br>Output Capacitance<br>Reverse Transfer Capacitance | $V_{DS} = 15\text{ V } f = 1\text{ MHz}, V_{GS} = 0$ |      | 315<br>87<br>17 |      | pF<br>pF<br>pF |

**ELECTRICAL CHARACTERISTICS** (continued)

**SWITCHING ON**

| Symbol                        | Parameter  | Test Conditions  | Min. | Typ.               | Max. | Unit           |
|-------------------------------|--|--|------|--------------------|------|----------------|
| $t_{d(on)}$<br>$t_r$          | Turn-on Delay Time<br>Rise Time                              | $V_{DD} = 10\text{ V}$ $I_D = 1\text{ A}$<br>$R_G = 4.7\ \Omega$ $V_{GS} = 4.5\text{ V}$<br>(Resistive Load, Figure 3) |      | 38<br>30           |      | ns<br>ns       |
| $Q_g$<br>$Q_{gs}$<br>$Q_{gd}$ | Total Gate Charge<br>Gate-Source Charge<br>Gate-Drain Charge | $V_{DD} = 10\text{ V}$ $I_D = 2\text{ A}$ $V_{GS} = 4.5\text{ V}$  |      | 3.5<br>0.34<br>0.8 | 4.7  | nC<br>nC<br>nC |

**SWITCHING OFF**

| Symbol                | Parameter                        | Test Conditions  | Min. | Typ.     | Max. | Unit     |
|-----------------------|----------------------------------|--|------|----------|------|----------|
| $t_{d(off)}$<br>$t_f$ | Turn-off Delay Time<br>Fall Time | $V_{DD} = 10\text{ V}$ $I_D = 1\text{ A}$<br>$R_G = 4.7\ \Omega$ , $V_{GS} = 4.5\text{ V}$<br>(Resistive Load, Figure 3) |      | 45<br>11 |      | ns<br>ns |

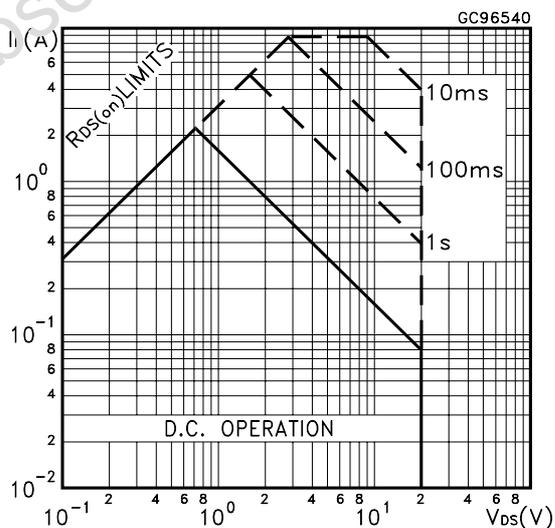
**SOURCE DRAIN DIODE**

| Symbol                            | Parameter  | Test Conditions  | Min. | Typ.           | Max.       | Unit          |
|-----------------------------------|--|--|------|----------------|------------|---------------|
| $I_{SD}$<br>$I_{SDM} (\bullet)$   | Source-drain Current<br>Source-drain Current (pulsed)                        |  |      |                | 2.2<br>8.8 | A<br>A        |
| $V_{SD} (*)$                      | Forward On Voltage   | $I_{SD} = 2\text{ A}$ $V_{GS} = 0$   |      |                | 1.2        | V             |
| $t_{rr}$<br>$Q_{rr}$<br>$I_{RRM}$ | Reverse Recovery Time<br>Reverse Recovery Charge<br>Reverse Recovery Current | $I_{SD} = 2\text{ A}$ $di/dt = 100\text{ A}/\mu\text{s}$<br>$V_{DS} = 10\text{ V}$ $T_j = 150^\circ\text{C}$<br>(see test circuit, Figure 5) |      | 15<br>7.5<br>1 |            | ns<br>nC<br>A |

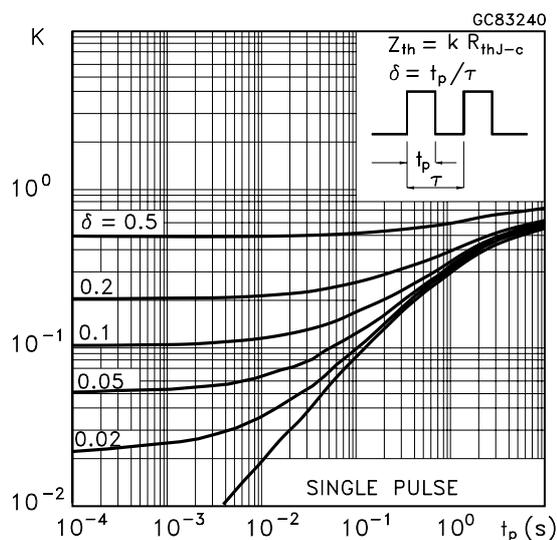
(\*) Pulsed: Pulse duration = 300  $\mu\text{s}$ , duty cycle 1:5 %.

( $\bullet$ ) Pulse width limited by safe operating area.

Safe Operating Area

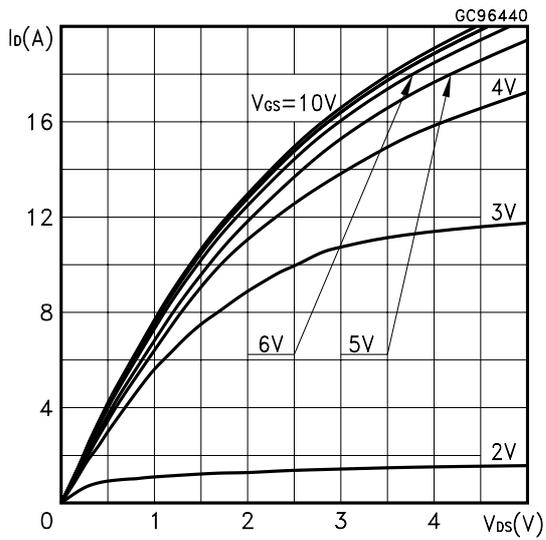


Thermal Impedance

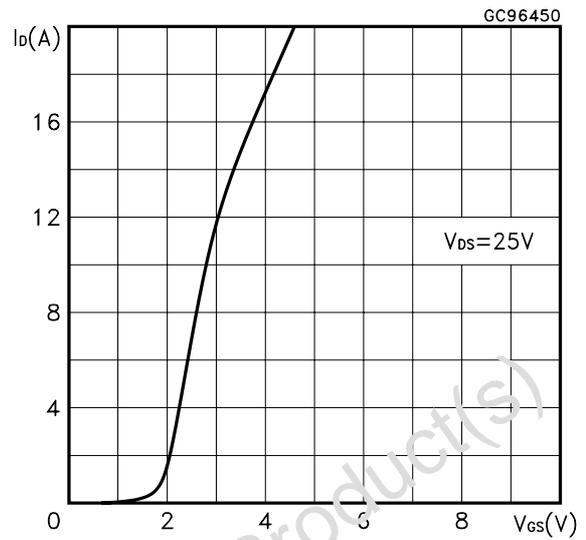


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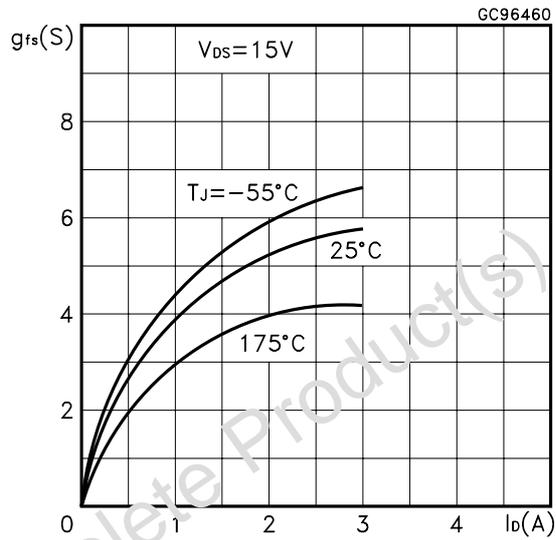
Output Characteristics



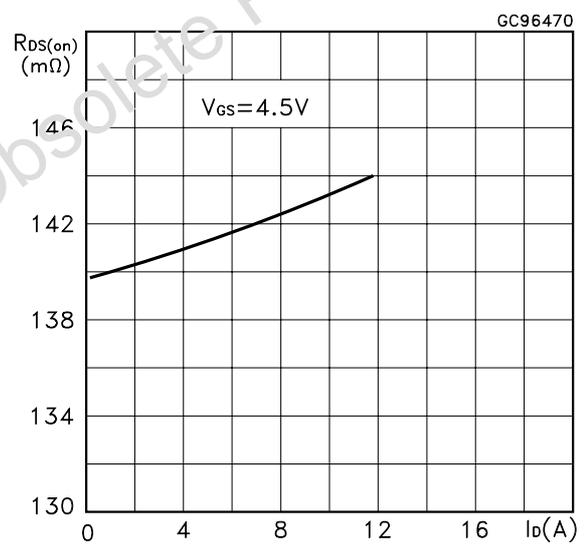
Transfer Characteristics



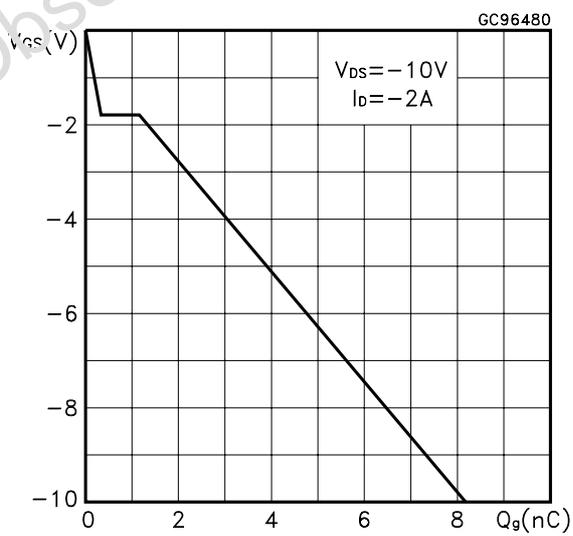
Transconductance



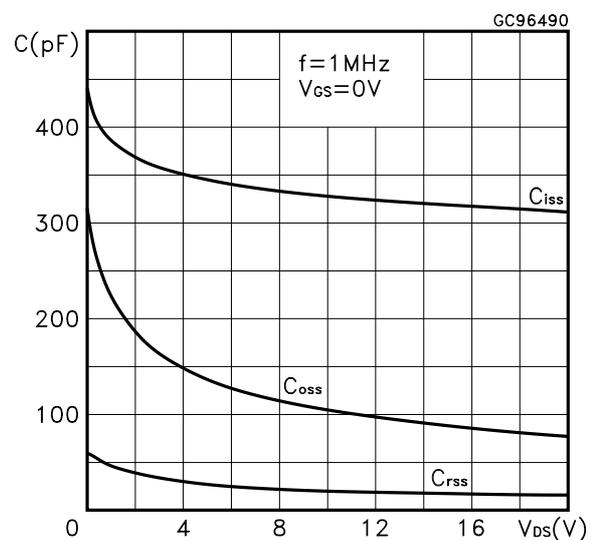
Static Drain-source On Resistance



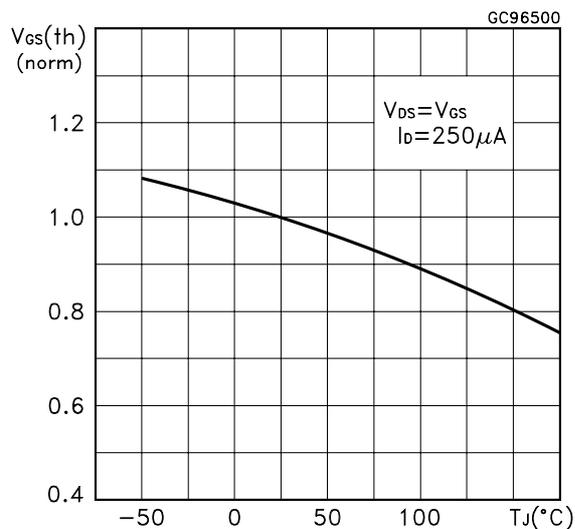
Gate Charge vs Gate-source Voltage



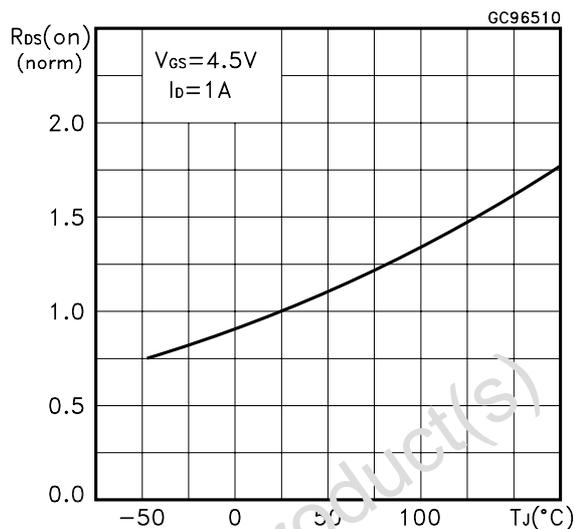
Capacitance Variations



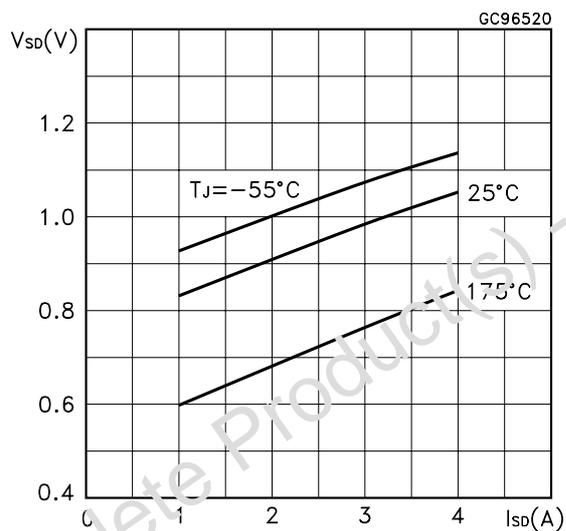
Normalized Gate Threshold Voltage vs Temperature



Normalized on Resistance vs Temperature



Source-drain Diode Forward Characteristics



Normalized Breakdown Voltage vs Temperature.

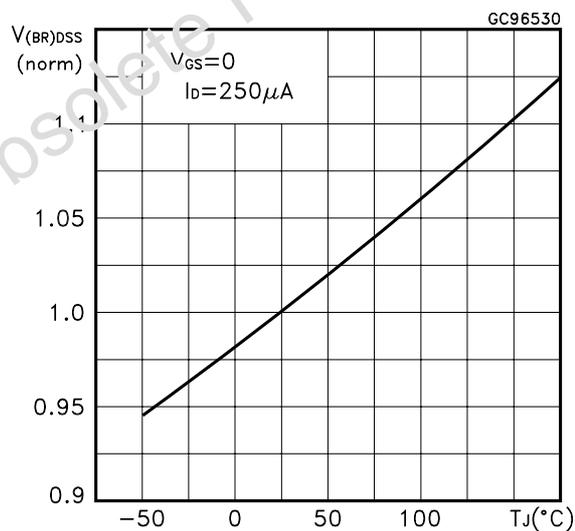


Fig. 1: Unclamped Inductive Load Test Circuit

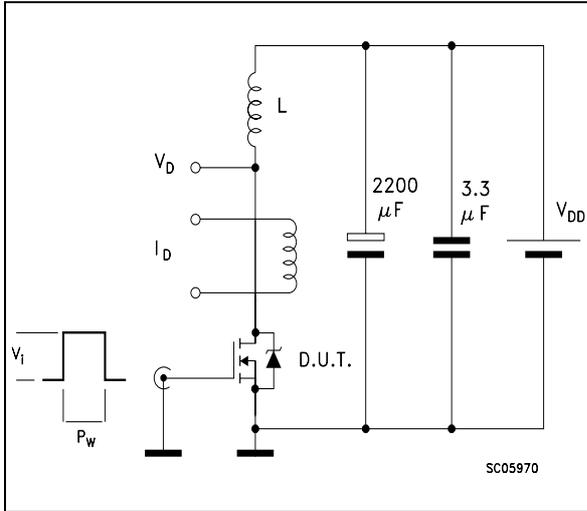


Fig. 2: Unclamped Inductive Waveform

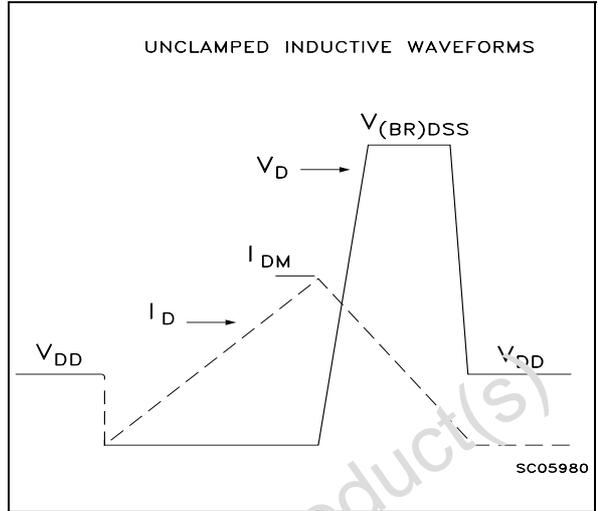


Fig. 3: Switching Times Test Circuits For Resistive Load

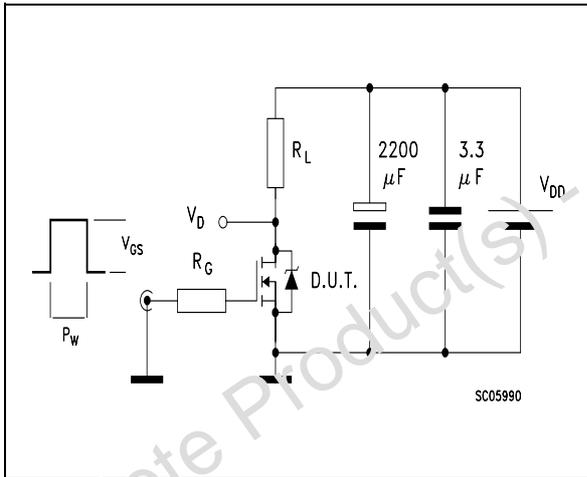


Fig. 4: Gate Charge test Circuit

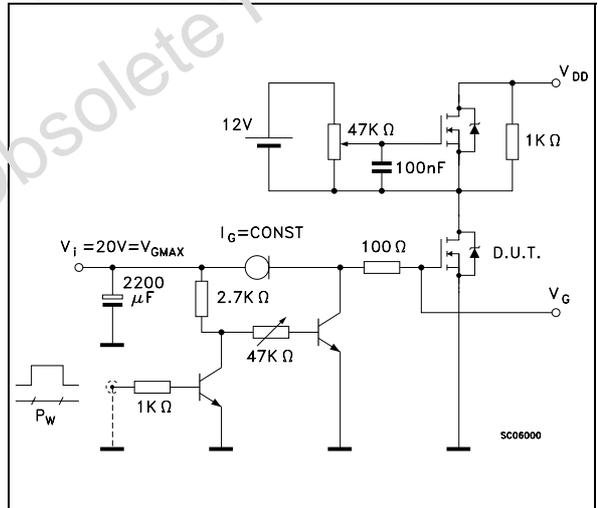
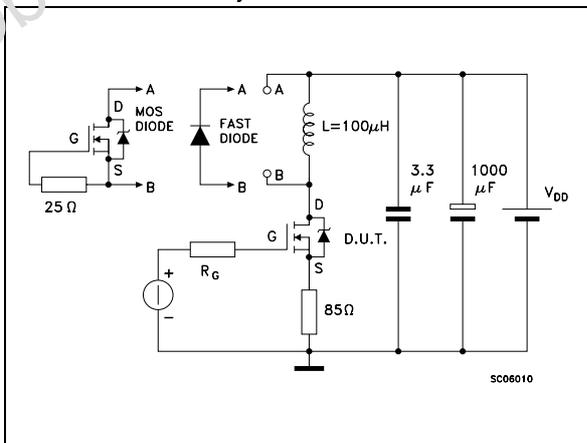
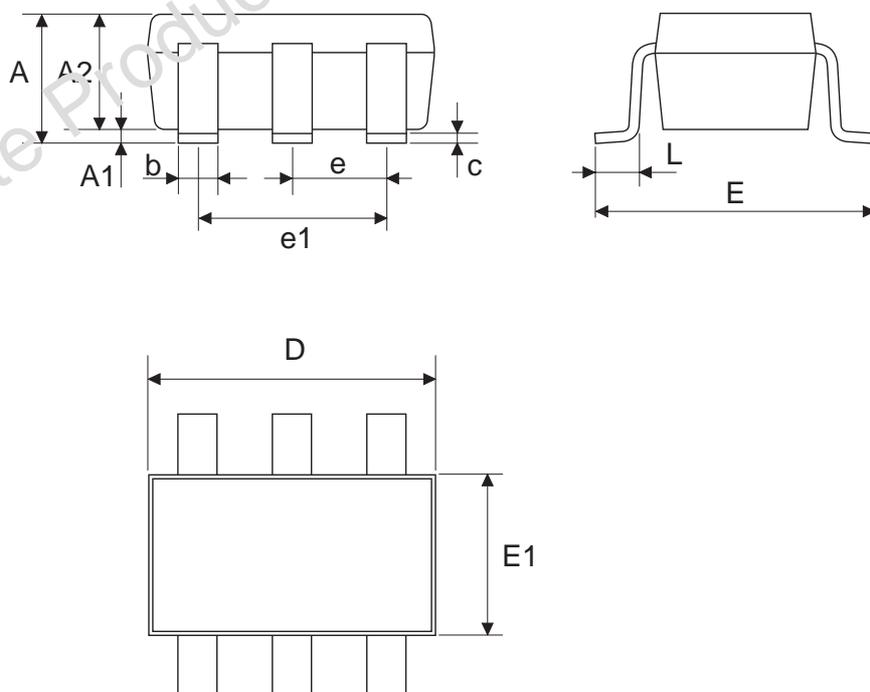


Fig. 5: Test Circuit For Inductive Load Switching And Diode Recovery Times



## SOT23-6L MECHANICAL DATA

| DIM. | mm   |      |      | mils  |       |       |
|------|------|------|------|-------|-------|-------|
|      | MIN. | TYP. | MAX. | MIN.  | TYP.  | MAX.  |
| A    | 0.90 |      | 1.45 | 0.035 |       | 0.057 |
| A1   | 0.00 |      | 0.15 | 0.000 |       | 0.006 |
| A2   | 0.90 |      | 1.30 | 0.035 |       | 0.051 |
| b    | 0.25 |      | 0.50 | 0.010 |       | 0.020 |
| C    | 0.09 |      | 0.20 | 0.004 |       | 0.008 |
| D    | 2.80 |      | 3.10 | 0.110 |       | 0.122 |
| E    | 2.60 |      | 3.00 | 0.102 |       | 0.118 |
| E1   | 1.50 |      | 1.75 | 0.059 |       | 0.069 |
| L    | 0.35 |      | 0.55 | 0.014 |       | 0.022 |
| e    |      | 0.95 |      |       | 0.037 |       |
| e1   |      | 1.90 |      |       | 0.075 |       |



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